

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/799,420	CHIU ET AL.	
Examiner	Art Unit	
Dang D. Le	2834	

SEARCHED				
Class	Subclass	Date	Examiner	
310	90 67R 156.12 to 156.15			
	156.26 91	6/17/2005	DL	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		<del></del>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
		<u>l</u> .